Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,103	OWEN ET AL.	
Examiner	Art Unit	
Samuel P. Siefke	1743	

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Class	Subclass	Date	Examiner
436	164,166 113,114 115,124, 159,143	slizlos	85
	149,143		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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